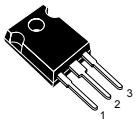
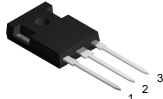


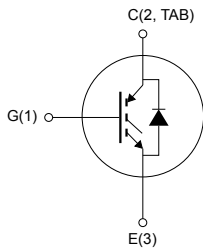
## Trench gate field-stop 650 V, 75 A low-loss M series IGBT in a TO-247 and TO-247 long leads packages



TO-247



TO-247 long leads



NG1E3C2T



### Features

- Maximum junction temperature:  $T_J = 175\text{ }^\circ\text{C}$
- 6  $\mu\text{s}$  of minimum short-circuit withstand time
- $V_{CE(sat)} = 1.65\text{ V (typ.) @ } I_C = 75\text{ A}$
- Tight parameter distribution
- Safer paralleling
- Positive  $V_{CE(sat)}$  temperature coefficient
- Low thermal resistance
- Soft and very fast-recovery antiparallel diode

### Applications

- Motor control
- UPS
- PFC
- General purpose inverter

### Description

These devices are IGBTs developed using an advanced proprietary trench gate field-stop structure. The devices are part of the M series IGBTs, which represent an optimal balance between inverter system performance and efficiency where the low-loss and the short-circuit functionality are essential. Furthermore, the positive  $V_{CE(sat)}$  temperature coefficient and the tight parameter distribution result in safer paralleling operation.

#### Product status links

[STGW75M65DF2](#)

[STGWA75M65DF2](#)

#### Product summary

Order code	STGW75M65DF2
Marking	G75M65DF2
Package	TO-247
Packing	Tube
Order code	STGWA75M65DF2
Marking	G75M65DF2
Package	TO-247 long leads
Packing	Tube

# 1 Electrical ratings

**Table 1. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{CES}$	Collector-emitter voltage ( $V_{GE} = 0$ V)	650	V
$I_C^{(1)}$	Continuous collector current at $T_C = 25$ °C	120	A
$I_C$	Continuous collector current at $T_C = 100$ °C	75	A
$I_{CP}^{(2)}$	Pulsed collector current	225	A
$V_{GE}$	Gate-emitter voltage	±20	V
$I_F^{(1)}$	Continuous forward current at $T_C = 25$ °C	120	A
$I_F$	Continuous forward current at $T_C = 100$ °C	75	A
$I_{FP}^{(2)}$	Pulsed forward current	225	A
$P_{TOT}$	Total power dissipation at $T_C = 25$ °C	468	W
$T_{STG}$	Storage temperature range	- 55 to 150	°C
$T_J$	Operating junction temperature range	- 55 to 175	°C

1. Limited by bonding wires.
2. Pulse width limited by maximum junction temperature.

**Table 2. Thermal data**

Symbol	Parameter	Value	Unit
$R_{thJC}$	Thermal resistance junction-case IGBT	0.32	°C/W
$R_{thJC}$	Thermal resistance junction-case diode	0.74	°C/W
$R_{thJA}$	Thermal resistance junction-ambient	50	°C/W

## 2 Electrical characteristics

$T_C = 25\text{ °C}$  unless otherwise specified

**Table 3. Static characteristics**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CES}$	Collector-emitter breakdown voltage	$V_{GE} = 0\text{ V}$ , $I_C = 250\text{ }\mu\text{A}$	650			V
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_{GE} = 15\text{ V}$ , $I_C = 75\text{ A}$		1.65	2.1	V
		$V_{GE} = 15\text{ V}$ , $I_C = 75\text{ A}$ , $T_J = 125\text{ °C}$		1.95		
		$V_{GE} = 15\text{ V}$ , $I_C = 75\text{ A}$ , $T_J = 175\text{ °C}$		2.1		
$V_F$	Forward on-voltage	$I_F = 75\text{ A}$		2	2.85	V
		$I_F = 75\text{ A}$ , $T_J = 125\text{ °C}$		1.75		
		$I_F = 75\text{ A}$ , $T_J = 175\text{ °C}$		1.6		
$V_{GE(th)}$	Gate threshold voltage	$V_{CE} = V_{GE}$ , $I_C = 2\text{ mA}$	5	6	7	V
$I_{CES}$	Collector cut-off current	$V_{GE} = 0\text{ V}$ , $V_{CE} = 650\text{ V}$			25	$\mu\text{A}$
$I_{GES}$	Gate-emitter leakage current	$V_{CE} = 0\text{ V}$ , $V_{GE} = \pm 20\text{ V}$			$\pm 250$	$\mu\text{A}$

**Table 4. Dynamic characteristics**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{ies}$	Input capacitance	$V_{CE} = 25\text{ V}$ , $f = 1\text{ MHz}$ , $V_{GE} = 0\text{ V}$	-	6290	-	pF
$C_{oes}$	Output capacitance		-	390	-	
$C_{res}$	Reverse transfer capacitance		-	136	-	
$Q_g$	Total gate charge	$V_{CC} = 520\text{ V}$ , $I_C = 75\text{ A}$ , $V_{GE} = 0\text{ to }15\text{ V}$ (see Figure 29)	-	225	-	nC
$Q_{ge}$	Gate-emitter charge		-	53	-	
$Q_{gc}$	Gate-collector charge		-	87	-	

**Table 5. IGBT switching characteristics (inductive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{CE} = 400\text{ V}$ , $I_C = 75\text{ A}$ , $V_{GE} = 15\text{ V}$ , $R_G = 3.3\ \Omega$ (see Figure 28)		47	-	ns
$t_r$	Current rise time			22.4	-	ns
$(di/dt)_{on}$	Turn-on current slope			2680	-	A/ $\mu$ s
$t_{d(off)}$	Turn-off-delay time			125	-	ns
$t_f$	Current fall time			93	-	ns
$E_{on}^{(1)}$	Turn-on switching energy			0.69	-	mJ
$E_{off}^{(2)}$	Turn-off switching energy			2.54	-	mJ
$E_{ts}$	Total switching energy		3.23	-	mJ	
$t_{d(on)}$	Turn-on delay time	$V_{CE} = 400\text{ V}$ , $I_C = 75\text{ A}$ , $V_{GE} = 15\text{ V}$ , $R_G = 3.3\ \Omega$ , $T_J = 175\text{ }^\circ\text{C}$ (see Figure 28)		48	-	ns
$t_r$	Current rise time			25	-	ns
$(di/dt)_{on}$	Turn-on current slope			2420	-	A/ $\mu$ s
$t_{d(off)}$	Turn-off-delay time			125	-	ns
$t_f$	Current fall time			167	-	ns
$E_{on}^{(1)}$	Turn-on switching energy			2.17	-	mJ
$E_{off}^{(2)}$	Turn-off switching energy			3.45	-	mJ
$E_{ts}$	Total switching energy		5.62	-	mJ	
$t_{sc}$	Short-circuit withstand time	$V_{CC} \leq 400\text{ V}$ , $V_{GE} = 13\text{ V}$ , $T_{Jstart} \leq 150\text{ }^\circ\text{C}$	10		-	$\mu$ s
		$V_{CC} \leq 400\text{ V}$ , $V_{GE} = 15\text{ V}$ , $T_{Jstart} \leq 150\text{ }^\circ\text{C}$	6			

1. Including the reverse recovery of the diode.
2. Including the tail of the collector current.

**Table 6. Diode switching characteristics (inductive load)**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{rr}$	Reverse recovery time	$I_F = 75\text{ A}$ , $V_R = 400\text{ V}$ , $V_{GE} = 15\text{ V}$ , $di/dt = 1000\text{ A}/\mu\text{s}$ (see Figure 28)	-	165	-	ns
$Q_{rr}$	Reverse recovery charge		-	1.72	-	$\mu$ C
$I_{rrm}$	Reverse recovery current		-	25	-	A
$dI_{rr}/dt$	Peak rate of fall of reverse recovery current during $t_b$		-	750	-	A/ $\mu$ s
$E_{rr}$	Reverse recovery energy		-	289	-	$\mu$ J
$t_{rr}$	Reverse recovery time	$I_F = 75\text{ A}$ , $V_R = 400\text{ V}$ , $V_{GE} = 15\text{ V}$ , $di/dt = 1000\text{ A}/\mu\text{s}$ , $T_J = 175\text{ }^\circ\text{C}$ (see Figure 28)	-	256	-	ns
$Q_{rr}$	Reverse recovery charge		-	6.85	-	$\mu$ C
$I_{rrm}$	Reverse recovery current		-	48	-	A
$dI_{rr}/dt$	Peak rate of fall of reverse recovery current during $t_b$		-	300	-	A/ $\mu$ s
$E_{rr}$	Reverse recovery energy		-	1033	-	$\mu$ J

## 2.1 STGWA75M65DF2 electrical characteristics curve

Figure 1. Power dissipation vs. case temperature

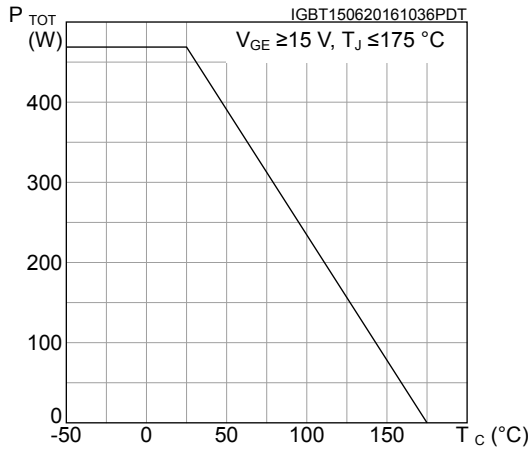


Figure 2. Collector current vs. case temperature

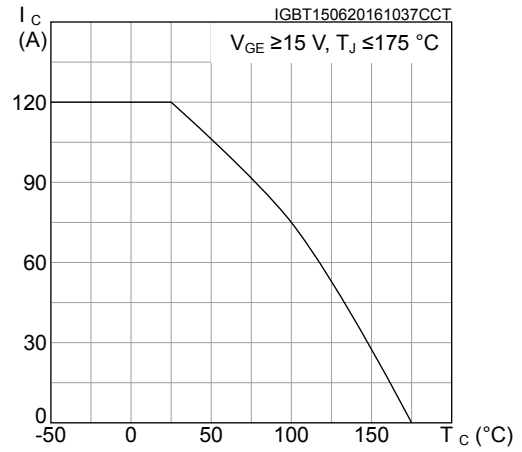


Figure 3. Output characteristics ( $T_J = 25\text{ °C}$ )

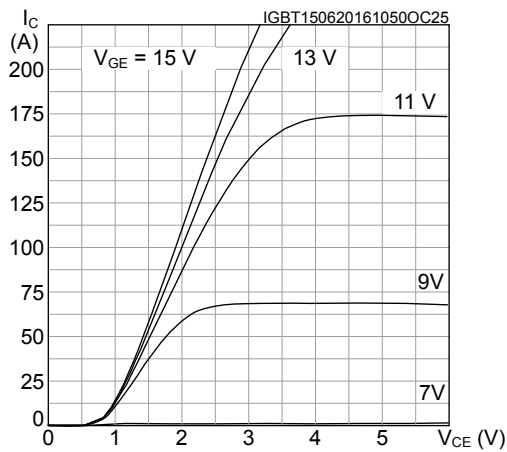


Figure 4. Output characteristics ( $T_J = 175\text{ °C}$ )

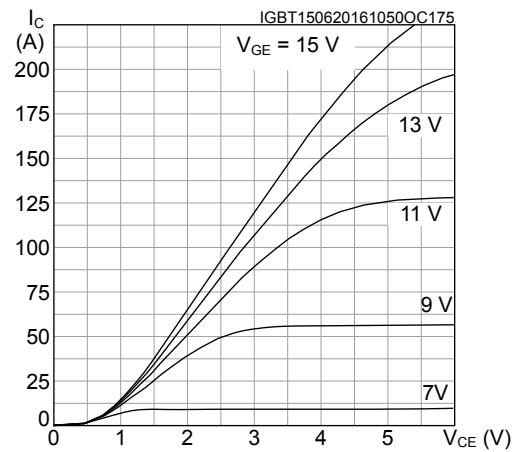


Figure 5.  $V_{CE(sat)}$  vs. junction temperature

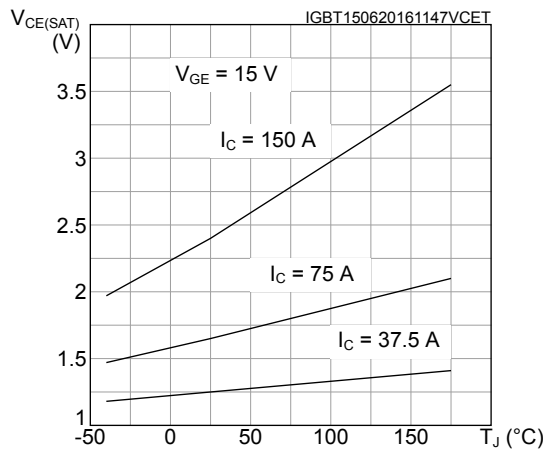
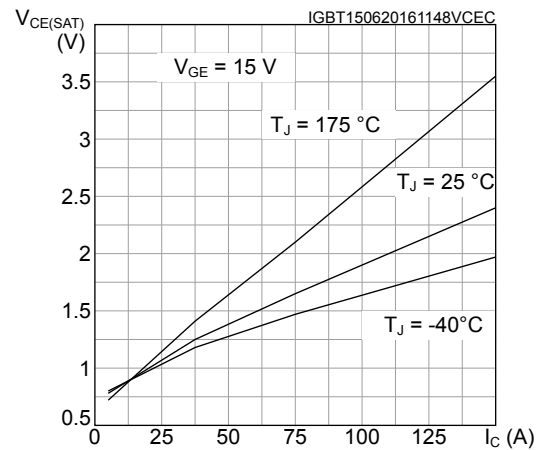
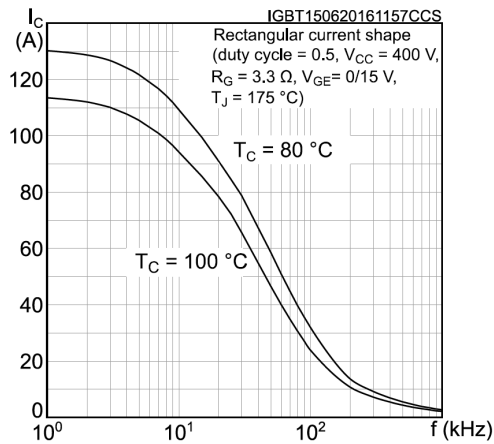
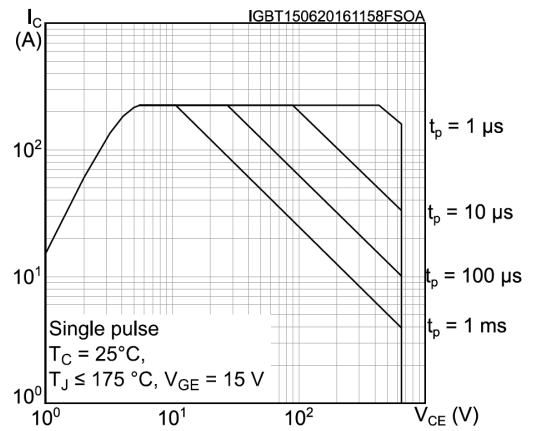
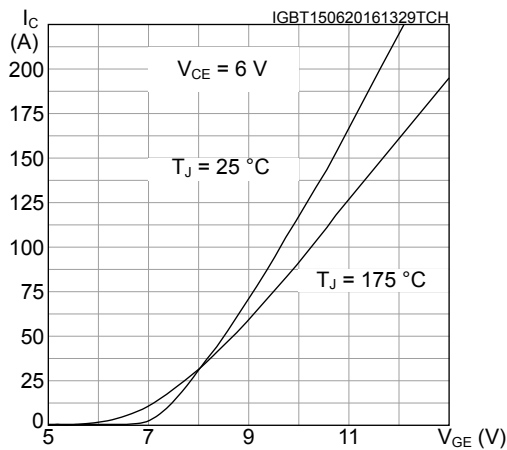
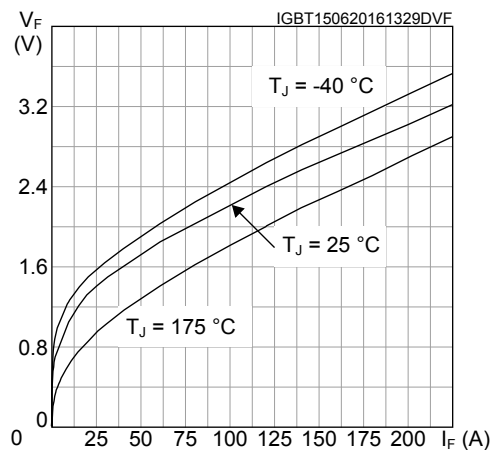
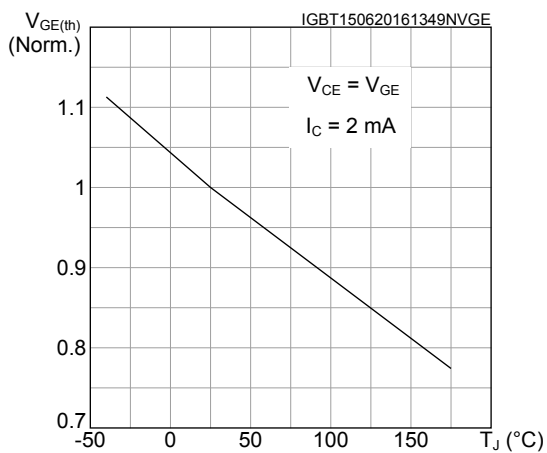
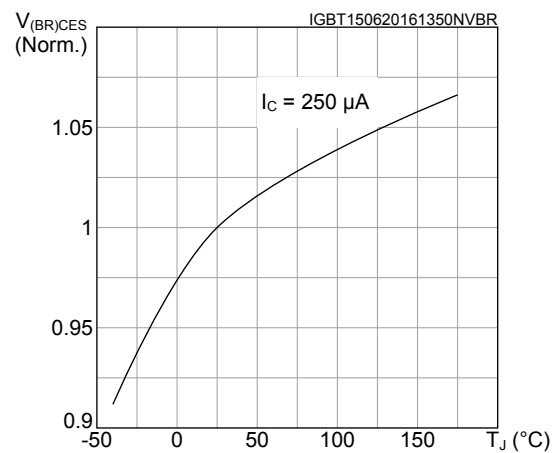
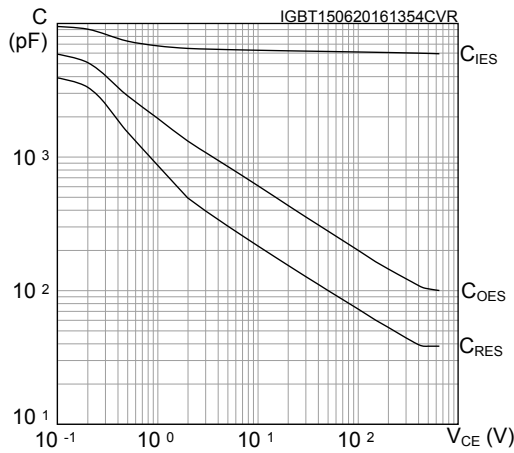
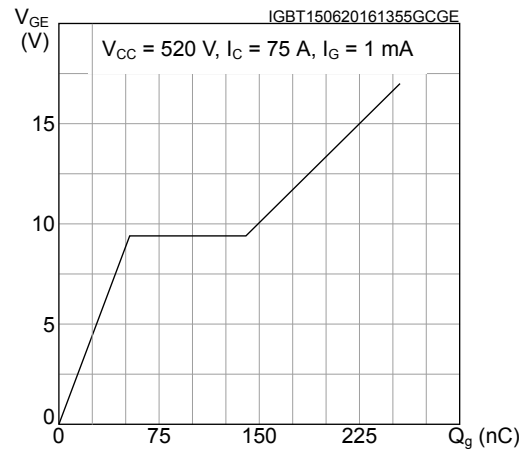
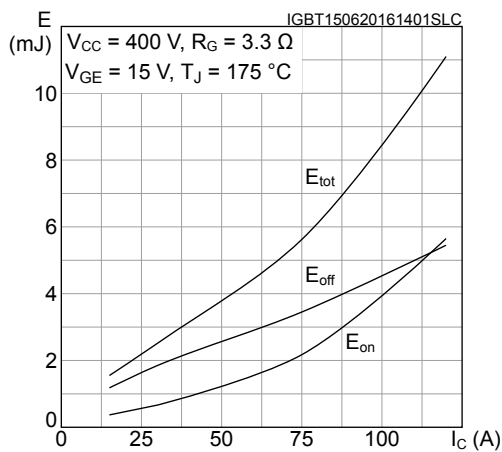
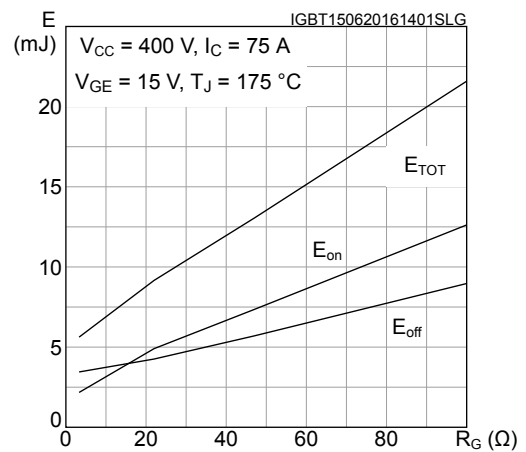
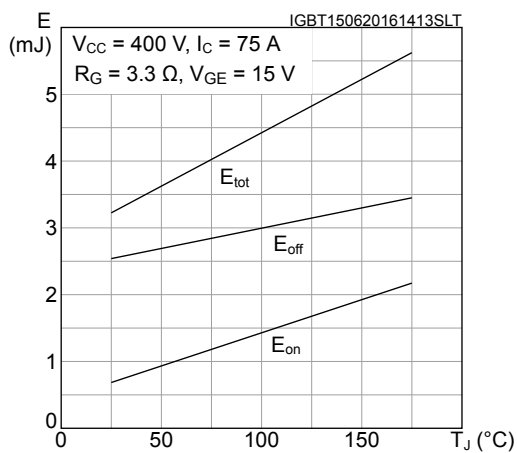
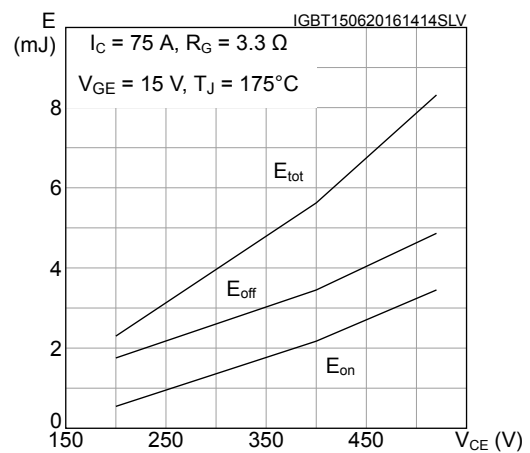
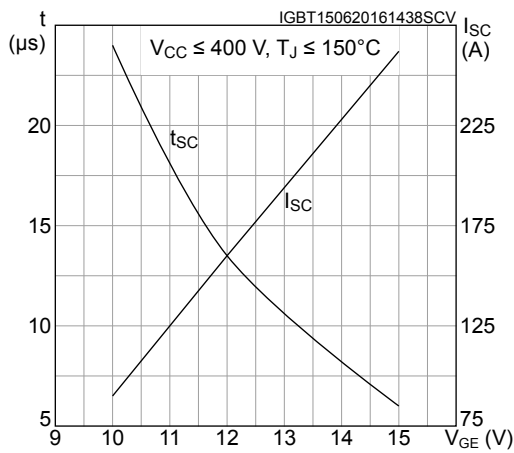
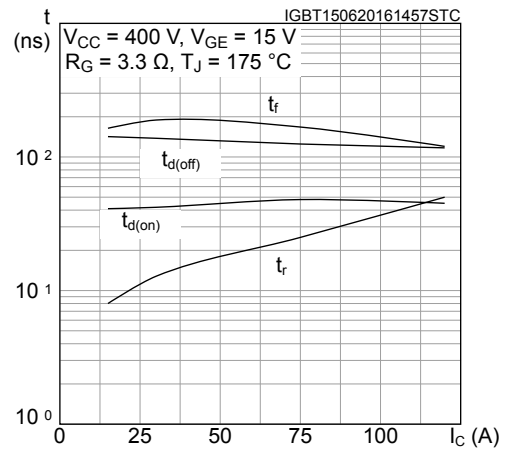
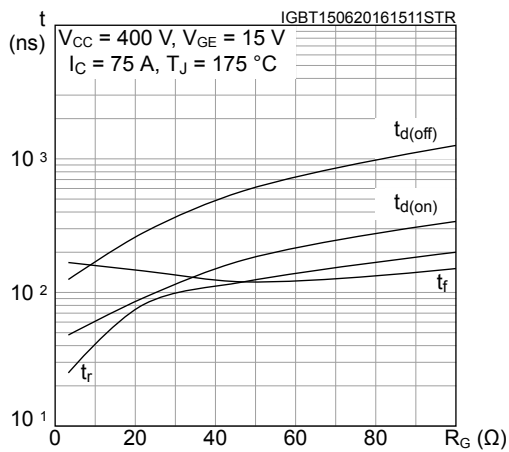
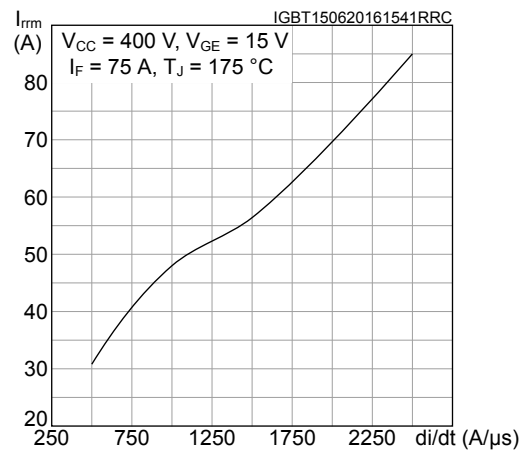
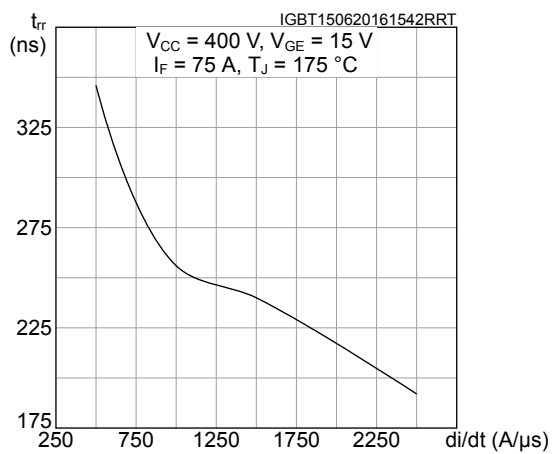
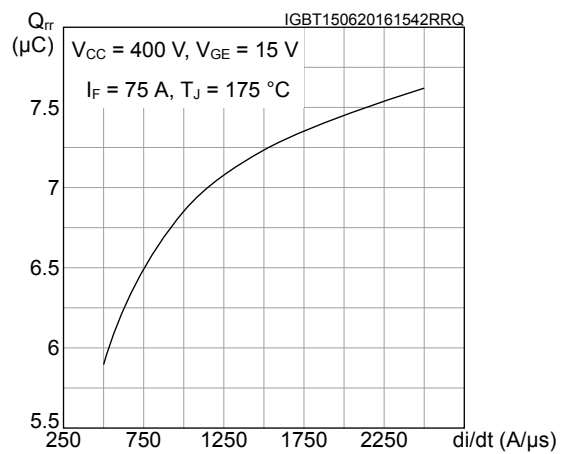


Figure 6.  $V_{CE(sat)}$  vs. collector current

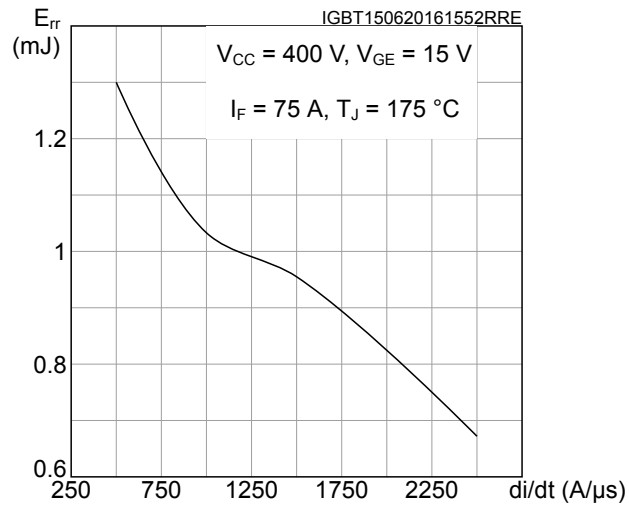
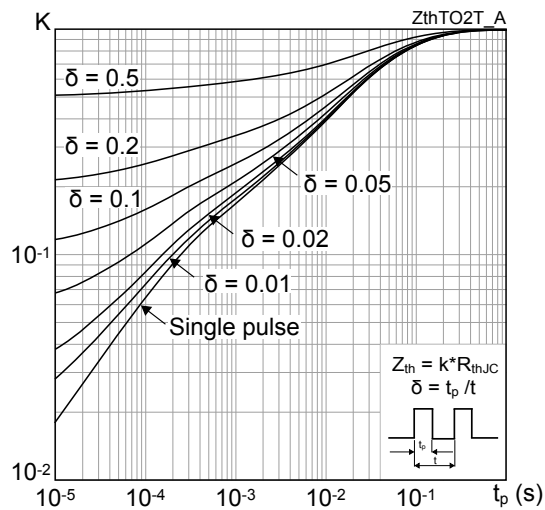
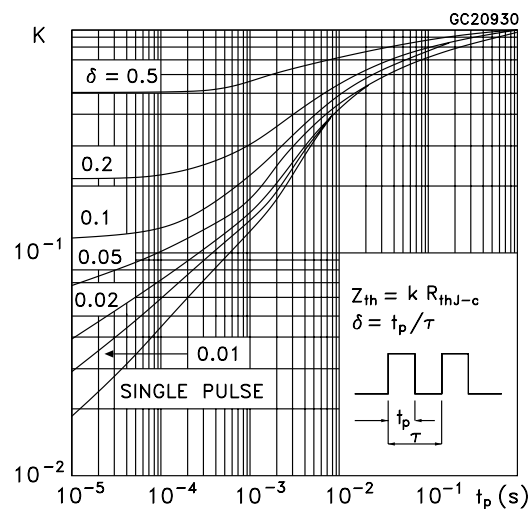


**Figure 7. Collector current vs. switching frequency**

**Figure 8. Forward bias safe operating area**

**Figure 9. Transfer characteristics**

**Figure 10. Diode VF vs. forward current**

**Figure 11. Normalized VGE(th) vs. junction temperature**

**Figure 12. Normalized V(BR)CES vs. junction temperature**


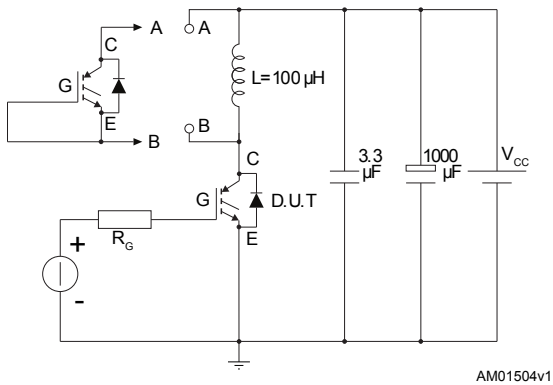
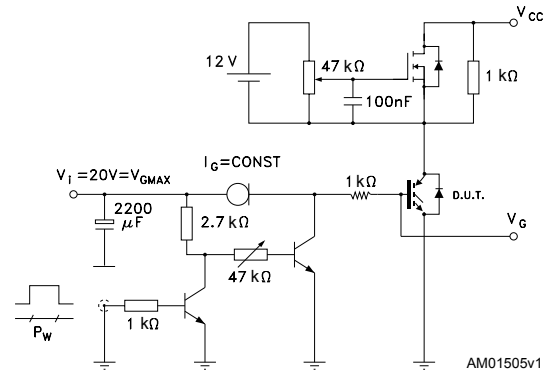
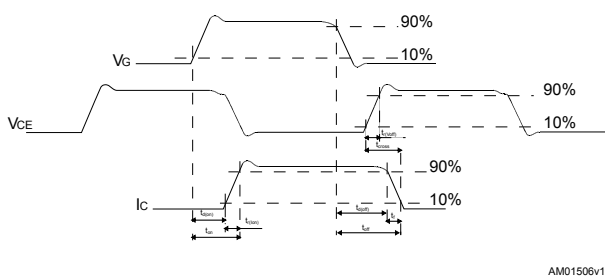
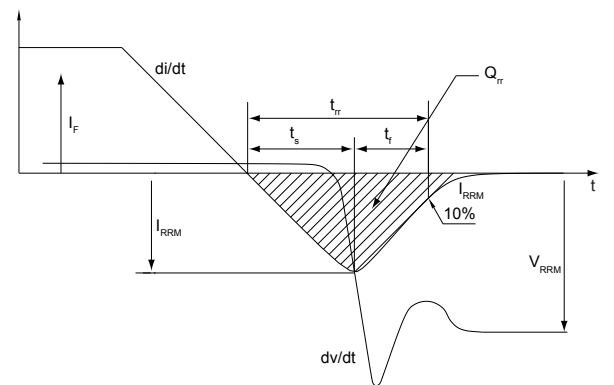
**Figure 13. Capacitance variations**

**Figure 14. Gate charge vs. gate-emitter voltage**

**Figure 15. Switching energy vs. collector current**

**Figure 16. Switching energy vs. gate resistance**

**Figure 17. Switching energy vs. temperature**

**Figure 18. Switching energy vs. collector emitter voltage**


**Figure 19. Short-circuit time and current vs.  $V_{GE}$** 

**Figure 20. Switching times vs. collector current**

**Figure 21. Switching times vs. gate resistance**

**Figure 22. Reverse recovery current vs. diode current slope**

**Figure 23. Reverse recovery time vs. diode current slope**

**Figure 24. Reverse recovery charge vs. diode current slope**




**Figure 25. Reverse recovery energy vs. diode current slope**

**Figure 26. Thermal impedance for IGBT**

**Figure 27. Thermal impedance for diode**


### 3 Test circuits

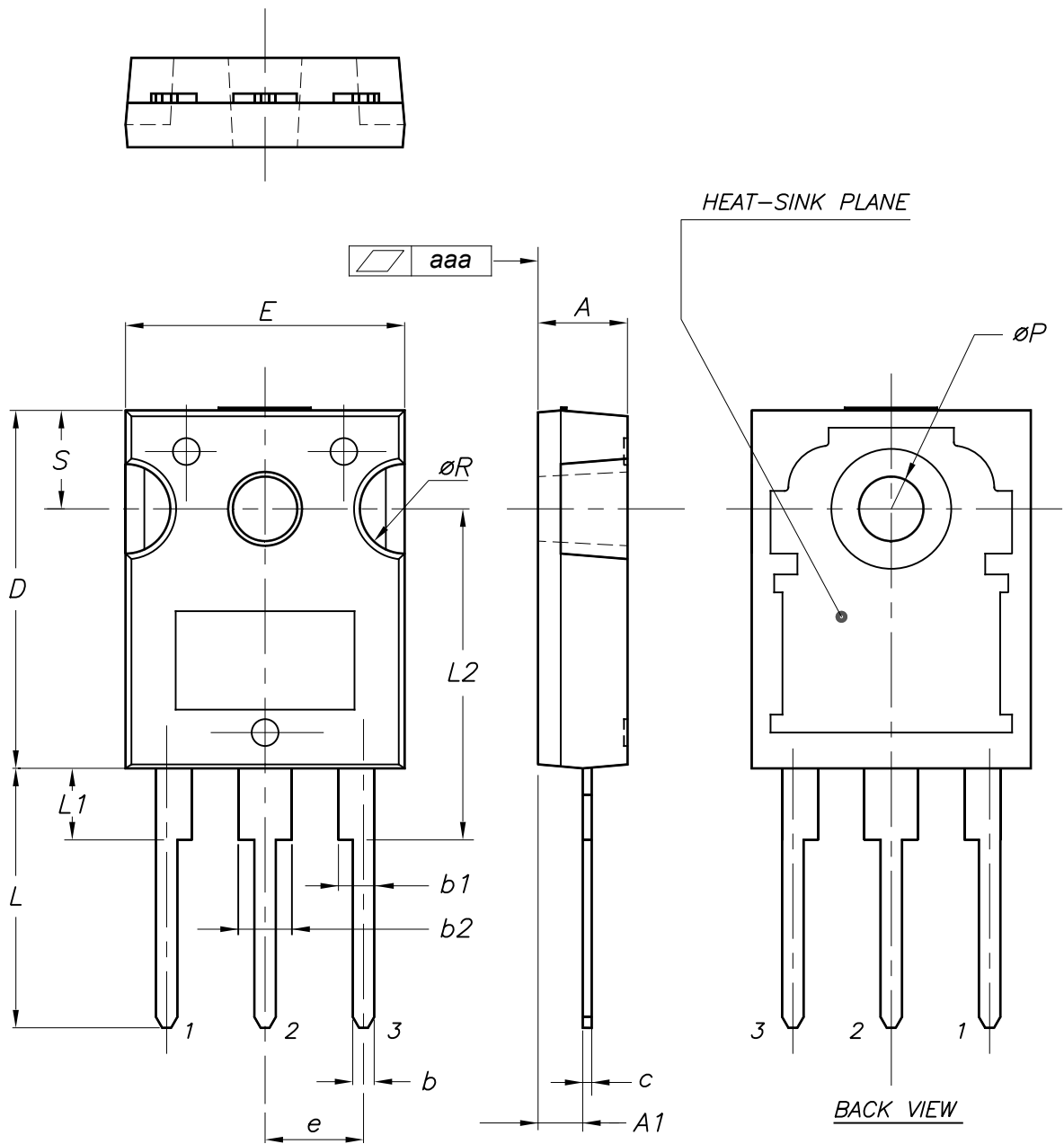
**Figure 28. Test circuit for inductive load switching**

**Figure 29. Gate charge test circuit**

**Figure 30. Switching waveform**

**Figure 31. Diode reverse recovery waveform**


## 4 Package information

To meet environmental requirements, ST offers these devices in different grades of **ECOPACK** packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions, and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

### 4.1 TO-247 package information

Figure 32. TO-247 package outline



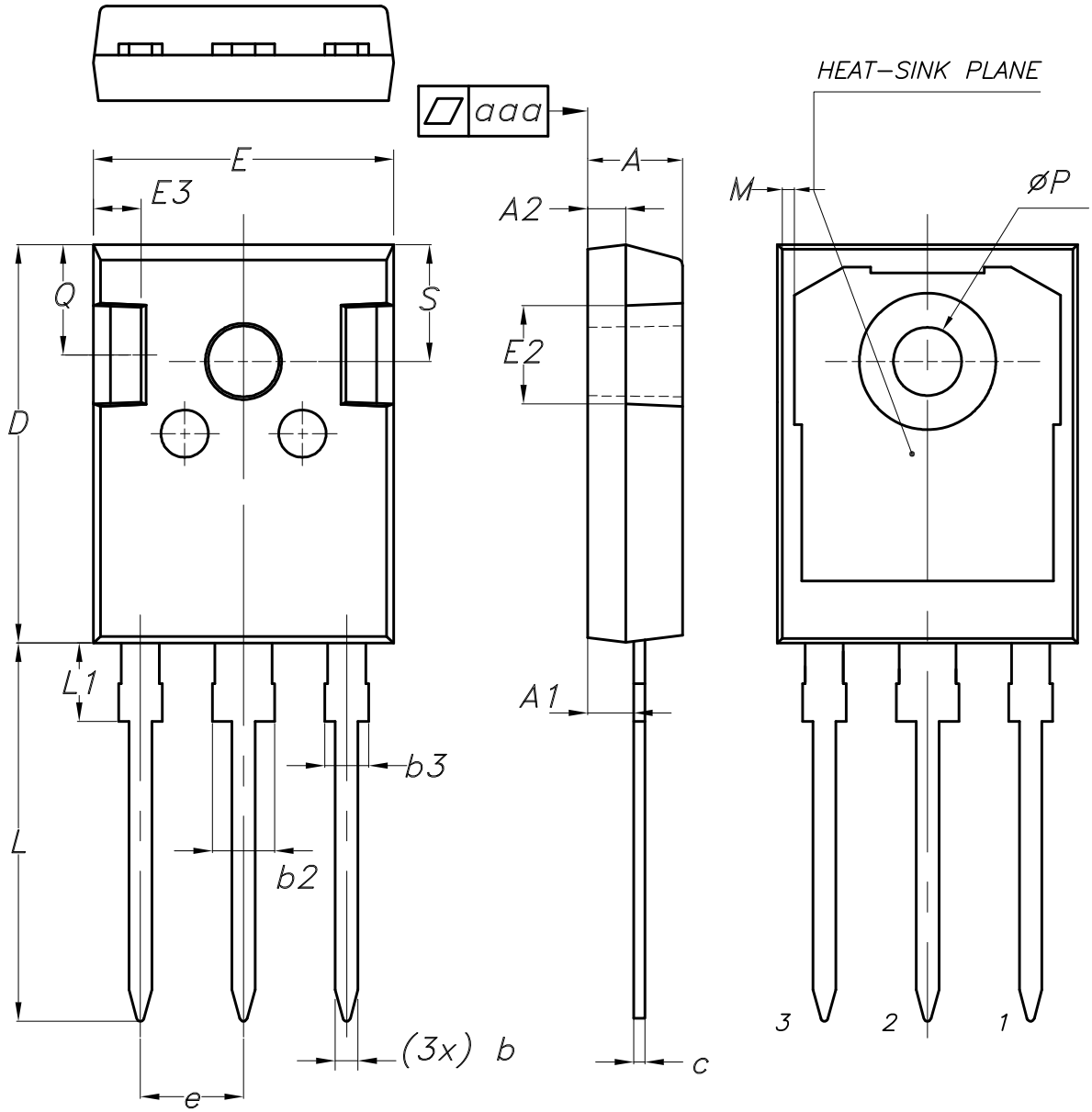
0075325\_10

**Table 7. TO-247 package mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
c	0.40		0.80
D	19.85		20.15
E	15.45		15.75
e	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70
aaa		0.04	0.10

## 4.2 TO-247 long leads package information

Figure 33. TO-247 long leads package outline



BACK VIEW

8463846\_5

**Table 8. TO-247 long leads package mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16		1.26
b2			3.25
b3			2.25
c	0.59		0.66
D	20.90	21.00	21.10
E	15.70	15.80	15.90
E2	4.90	5.00	5.10
E3	2.40	2.50	2.60
e	5.34	5.44	5.54
L	19.80	19.92	20.10
L1			4.30
M	0.35		0.95
P	3.50	3.60	3.70
Q	5.60		6.00
S	6.05	6.15	6.25
aaa		0.04	0.10

## Revision history

**Table 9. Document revision history**

Date	Revision	Changes
02-Dec-2015	1	First release.
15-Jun-2016	2	<p>Inserted device in TO-247 and document updated accordingly.</p> <p>Inserted <i>Section 2.1: "Electrical characteristics (curves)"</i>.</p> <p>Document status promoted from preliminary to production data.</p> <p>Minor text changes.</p>
03-May-2017	3	<p>Modified: title, features and application on cover page.</p> <p>Modified Table 4: "Static characteristics", Table 7: "Diode switching characteristics (inductive load)" and Figure 13: "Normalized V(BR)CES vs. junction temperature".</p> <p>Minor text changes.</p>
20-Jan-2025	4	<p>Updated <a href="#">Section 4.1: TO-247 package information</a>, and <a href="#">Section 4.2: TO-247 long leads package information</a>.</p> <p>Updated document title on cover page.</p> <p>Minor text changes.</p>



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